Product data sheet COMPANY PUBLIC

1 General description

The BGU8052 is, also known as the BGTS1001M, a low noise high linearity amplifier for wireless infrastructure applications, equipped with fast shutdown to support TDD systems. The LNA has a high input and output return loss and is designed to operate between 1.5 GHz and 2.5 GHz. It is housed in a 2 mm \times 2 mm \times 0.75 mm 8-terminal plastic thin small outline package. The LNA is ESD protected on all terminals.

2 Features and benefits

- Low noise performance: NF = 0.50 dB
- High linearity performance: IP3_O = 36 dBm
- High input return loss > 15 dB
- High output return loss > 20 dB
- Unconditionally stable up to 20 GHz
- Programmable bias current (via resistor)
- Small 8-terminal leadless package 2 mm × 2 mm × 0.75 mm
- · ESD protection on all terminals
- · Moisture sensitivity level 1
- Fast shut down to support TDD systems
- 3 V to 5 V single supply

3 Applications

- · Wireless infrastructure
- · Low noise and high linearity applications
- LTE, W-CDMA, CDMA, GSM
- · General-purpose wireless applications
- TDD or FDD systems
- · Suitable for small cells



Low noise high linearity amplifier

4 Quick reference data

Table 1. Quick reference data

f = 1900 MHz; V_{CC} = 5 V; T_{amb} = 25 °C; input and output 50 Ω ; R_{bias} = 5.1 $k\Omega$; unless otherwise specified. All RF parameters are measured in an application board as shown in Figure 16 with components listed in Table 9 optimized for f = 1900 MHz.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I _{CC}	supply current	on state	36	48	60	mA
		off state	-	2.8	-	mA
G _{ass}	associated gain	on state	17	18.5	20	dB
		off state	-	-23	-	dB
NF	noise figure	[1]	-	0.50	0.70	dB
P _{L(1dB)}	output power at 1 dB gain compression		-	18	-	dBm
IP3 _O	output third-order intercept point	2-tone; tone spacing = 1 MHz;P _i = -15 dBm per tone	32	36	-	dBm

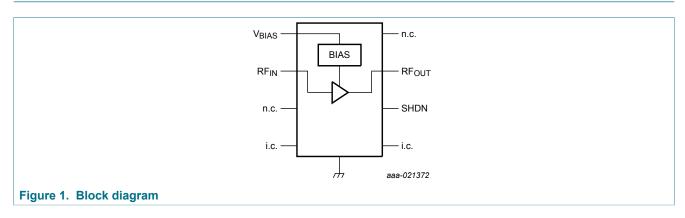
^[1] Connector and Printed-Circuit Board (PCB) losses have been de-embedded.

5 Ordering information

Table 2. Ordering information

Type number	Package	Package							
	Name	Description	Version						
BGU8052	HWSON8	plastic thermal enhanced very very thin small outline package; no leads; 8 terminals; body 2 × 2 × 0.75 mm	SOT1327-1						

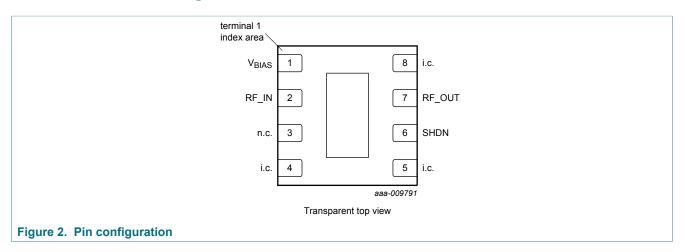
6 Block diagram



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7 Pinning information

7.1 Pinning



7.2 Pin description

Table 3. Pin description

Symbol	Pin	Description
V_{BIAS}	1	bias voltage
RF_IN	2	RF input
n.c.	3	not connected
i.c.	4, 5, 8	internally connected. Can be grounded or left open in the application.
SHDN	6	shutdown
RF_OUT	7	RF output
GND	exposed die pad	ground

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Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CC}	supply voltage		-	6	V
V _{ctrl(sd)}	shutdown control voltage		-	3	V
I _{CC}	supply current		-	85	mA
P _{i(RF)CW}	continuous waveform RF input power		-	20	dBm
T _{stg}	storage temperature		-40	+150	°C
Tj	junction temperature		-	150	°C
Р	power dissipation	T _{case} ≤ 125 °C [1]	-	510	mW
V _{ESD}	electrostatic discharge voltage	Human Body Model (HBM) According to ANSI/ESDA/JEDEC standard JS-001-2010	_	1.5	kV
		Charged Device Model (CDM); According to JEDEC standard 22-C101B	-	2	kV

Case is ground solder pad.

Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CC}	supply voltage		3.3	5	5.25	V
Z_0	characteristic impedance		-	50	-	Ω
T _{case}	case temperature		-40	-	+85	°C

10 Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
$R_{\text{th(j-case)}}$	thermal resistance from junction to case	[1] [2]	50	K/W

Case is ground solder pad.

Thermal resistance measured using infrared measurement technique, device mounted on application board and placed in still air.

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11 Characteristics

Table 7. Characteristics

f = 1900 MHz; V_{CC} = 5 V; T_{amb} = 25 °C; input and output 50 Ω ; R_{bias} = 5.1 $k\Omega$; unless otherwise specified. All RF parameters are measured in an application board as shown in Figure 16 with components listed in Table 9 optimized for f = 1900 MHz.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I _{CC}	supply current	on state		36	48	60	mA
		off state		-	2.8	-	mA
G _{ass}	associated gain	on state		17	18.5	20	dB
		off state		-	-23	-	dB
NF	noise figure		[1]	-	0.50	0.70	dB
P _{L(1dB)}	output power at 1 dB gain compression			-	18	-	dBm
IP3 _O	output third-order intercept point	2-tone; tone spacing = 1 MHz;P _i = -15 dBm per tone		32	36	-	dBm
		2-tone; tone spacing = 1 MHz;P _i = -15 dBm per tone	[2]	30	34	-	dBm
RLin	input return loss	on state		-	14.5	-	dB
		off state		-	8.4	-	dB
RLout	output return loss			-	23	-	dB
ISL	isolation			-	23	-	dB
t _{s(pon)}	power-on settling time	P _i = -20 dBm; SHDN (pin 6) from HIGH to LOW	[2]	-	1.4	-	μs
t _{s(poff)}	power-off settling time	P_i = -20 dBm; SHDN (pin 6) from LOW to HIGH	[2]	-	0.4	-	μs
K	Rollett stability factor	both on state and off state up to f = 20 GHz		1	-	-	
R _{pd(SHDN)}	pull-down resistance on pin SHDN			-	20	-	kΩ

^[1] Connector and Printed-Circuit Board (PCB) losses have been de-embedded.

Table 8. Shutdown control

 V_{CC} = 5 V; T_{amb} = 25 °C.

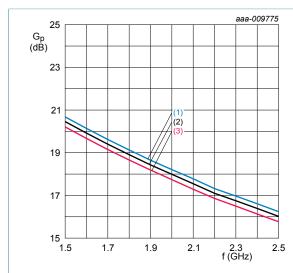
State	V _{ctrl(sd)} ^[1]	Unit
on state	≤ 0.6	V
off state	≥ 1.2	V

[1] Voltage on pin 6 (SHDN).

^[2] For TDD systems where fast switching is required, the value of C1 and C2 should be changed to 100 pF.

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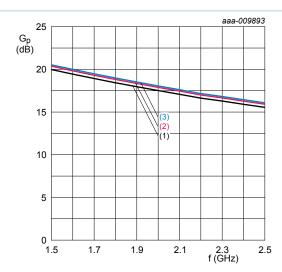
11.1 Graphics



 V_{CC} = 5 V; I_{CC} = 48 mA.

- (1) T_{amb} =-40°C
- (2) $T_{amb} = +25^{\circ}C$
- (3) $T_{amb} = +85^{\circ}C$

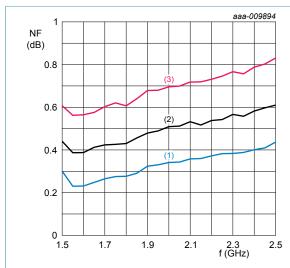
Figure 3. Power gain as a function of frequency; typical values



V_{CC}= 5 V; T_{amb}= 25°C.

- (1) I_{CC} = 30 mA
- (2) I_{CC} = 45 mA
- (3) I_{CC} = 60 mA

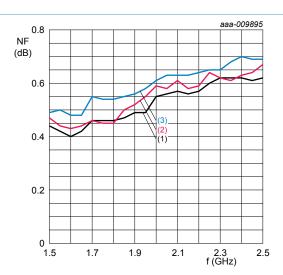
Figure 4. Power gain as a function of frequency; typical values



 V_{CC} = 5 V; I_{CC} = 48 mA.

- (1) T_{amb} =-40°C
- (2) $T_{amb} = +25^{\circ}C$
- (3) $T_{amb} = +85^{\circ}C$

Figure 5. Noise figure as a function of frequency; typical Figure 6. Noise figure as a function of frequency; typical



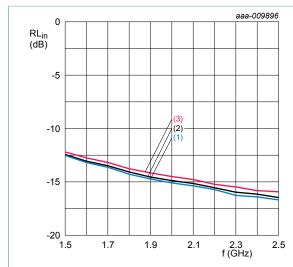
V_{CC}= 5 V; T_{amb}= 25°C.

- (1) I_{CC} = 30 mA
- (2) I_{CC} = 45 mA
- (3) I_{CC} = 60 mA

values

BGU8052

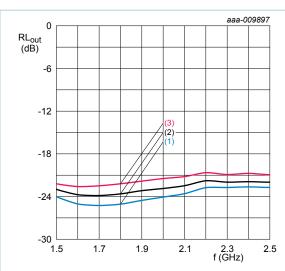
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 V_{CC} = 5 V; I_{CC} = 48 mA.

- (1) T_{amb}=-40°C
- (2) $T_{amb} = +25^{\circ}C$
- (3) $T_{amb} = +85^{\circ}C$

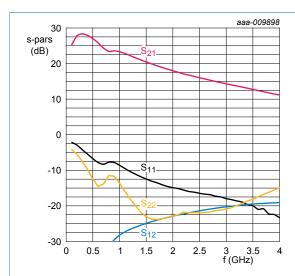
Figure 7. Input return loss as a function of frequency; typical values



V_{CC}= 5 V; I_{CC}= 48 mA.

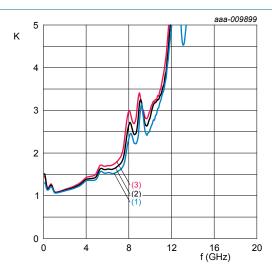
- (1) T_{amb} =-40°C
- (2) $T_{amb} = +25^{\circ}C$
- (3) $T_{amb} = +85^{\circ}C$

Figure 8. Output return loss as a function of frequency; typical values



 V_{CC} = 5 V; T_{amb} = 25°C; I_{CC} = 48 mA.

Figure 9. Wideband S-parameters as function of frequency; typical value

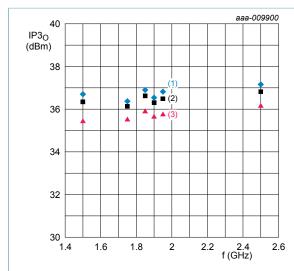


 V_{CC} = 5 V; I_{CC} = 48 mA.

- (1) $T_{amb} = -40^{\circ}C$
- (2) $T_{amb} = +25^{\circ}C$
- (3) $T_{amb} = +85^{\circ}C$

Figure 10. Rollett stability factor as a function of frequency; typical values

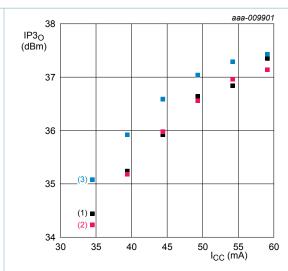
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 V_{CC} = 5 V; P_i =-15 dBm per tone; I_{CC} = 48 mA.

- (1) T_{amb}=-40°C
- (2) $T_{amb} = +25^{\circ}C$
- (3) $T_{amb} = +85^{\circ}C$

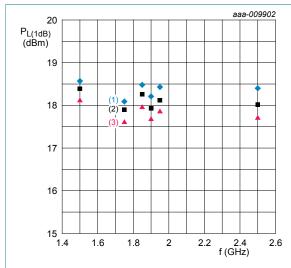
Figure 11. Output third-order intercept point as a function of frequency; typical values



 V_{CC} = 5 V; P_i =-15 dBm per tone; T_{amb} = 25°C.

- (1) f = 1500 MHz
- (2) f = 1900 MHz
- (3) f = 2500 MHz

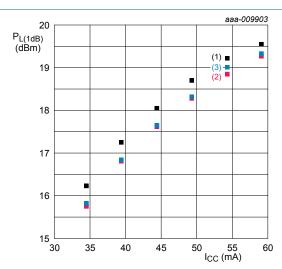
Figure 12. Output third-order intercept point as a function of supply current; typical values



 V_{CC} = 5 V; I_{CC} = 48 mA.

- (1) T_{amb}=-40°C
- (2) $T_{amb} = +25^{\circ}C$
- (3) $T_{amb} = +85^{\circ}C$

Figure 13. Output power at 1 dB gain compression as a function of frequency; typical values

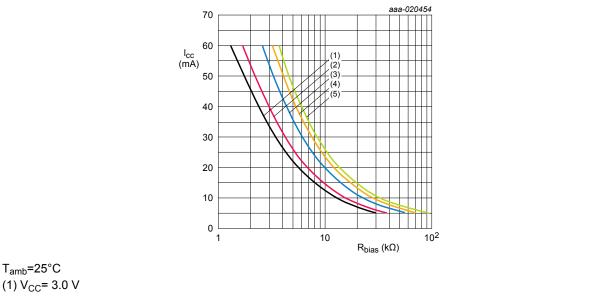


 V_{CC} = 5 V; T_{amb} = 25°C

- (1) f = 1500 MHz
- (2) f = 1900 MHz
- (3) f = 2500 MHz

Figure 14. Output power at 1 dB gain compression as a function of supply current; typical values

Low noise high linearity amplifier



(2) V_{CC} = 3.3 V (3) V_{CC} = 4.0 V

(4) V_{CC}= 4.5 V

(5) V_{CC}= 5 V

Figure 15. I_{CC} as a function of R_{bias} , typical values

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12 Application information

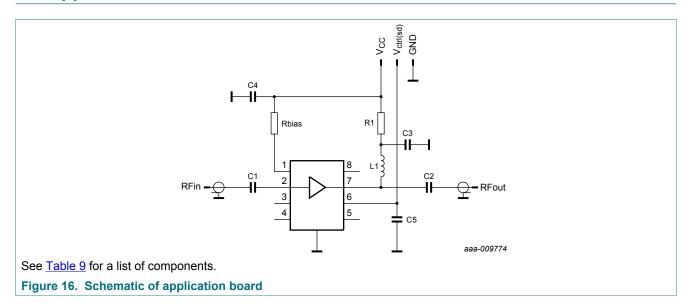


Table 9. List of components

See Figure 16 for schematics.

Component	Description	Value	Remarks
C1, C2	capacitor	100 nF	
		100 pF	recommended for TDD systems
C3	capacitor	10 pF	
C4	capacitor	5.6 nF	
C5	capacitor	10 pF	
L1	inductor	15 nH	
R1	resistor	10 Ω	
R _{bias}	resistor	5.1 kΩ	V _{CC} = 5 V
		2.3 kΩ	V _{CC} = 3.3 V

Low noise high linearity amplifier

Table 10. Typical performance BGU8052 application boardV_{CC} = 5 V

All RF parameters are measured at the application board as shown in Figure 16 with the components as listed in Table 9 while optimized for: f = 1900 MHz; V_{CC} = 5 V; I_{CC} = 48 mA and T_{amb} = 25 °C.

Symbol	Parameter	Conditions	f (MHz)								
			1500	1750	1850	1900	1950	2100	2300	2500	
G	gain		20.5	19.2	18.7	18.4	18.2	17.6	16.8	16.0	
RLin	input return loss		12.4	13.8	14.3	14.5	14.7	15.2	16.0	16.5	
RL _{out}	output return loss		23.0	23.7	23.4	23.2	23.0	22.5	22.0	22.0	
P _{L(1dB)}	output power at 1 dB gain compression		18.5	18.9	18.5	19.0	18.0	18.8	18.2	17.2	
IP3 _O	output third-order intercept	[1]	36.8	36.2	36.3	36.3	36.0	36.3	35.6	35.4	
point	point	[1] [2]	37.5	37.4	37.2	37.0	36.7	35.7	36.5	35.3	
NF	noise figure	[3]	0.44	0.43	0.46	0.48	0.49	0.53	0.57	0.61	

Table 11. Typical performance BGU8052 application board V_{CC} = 3.3 V

All RF parameters measured at application board shown in Figure 16. The components listed in Table 9 optimized for 1900 MHz; V_{CC} =3.3 V; I_{CC} = 48 mA; T_{amb} = 25 °C.

Symbol	Parameter	Conditions	f (MHz)								
			1500	1750	1850	1900	1950	2100	2300	2500	
G	gain		20.5	19.2	18.7	18.4	18.2	17.6	16.8	16.5	
RLin	input return loss		12.3	13.9	14.5	14.7	14.5	14.8	15.3	15.5	
RLout	output return loss		21.6	23.5	24.0	23.8	23.3	22.6	21.2	20.4	
P _{L(1dB)}	output power at 1 dB gain compression		16.2	16.0	16.0	16.2	15.8	15.8	15.5	14.9	
IP3 _O	output third-order intercept	[1]	33.3	32.9	31.9	32.5	32.0	31.6	30.6	31.1	
point	point	[1] [2]	31.8	31.6	31.2	31.0	31.2	30.6	30.5	29.5	
NF	noise figure	[3]	0.42	0.47	0.48	0.49	0.50	0.53	0.56	0.58	

² tone; spacing 1 MHz, P_0 = 5 dBm per tone.

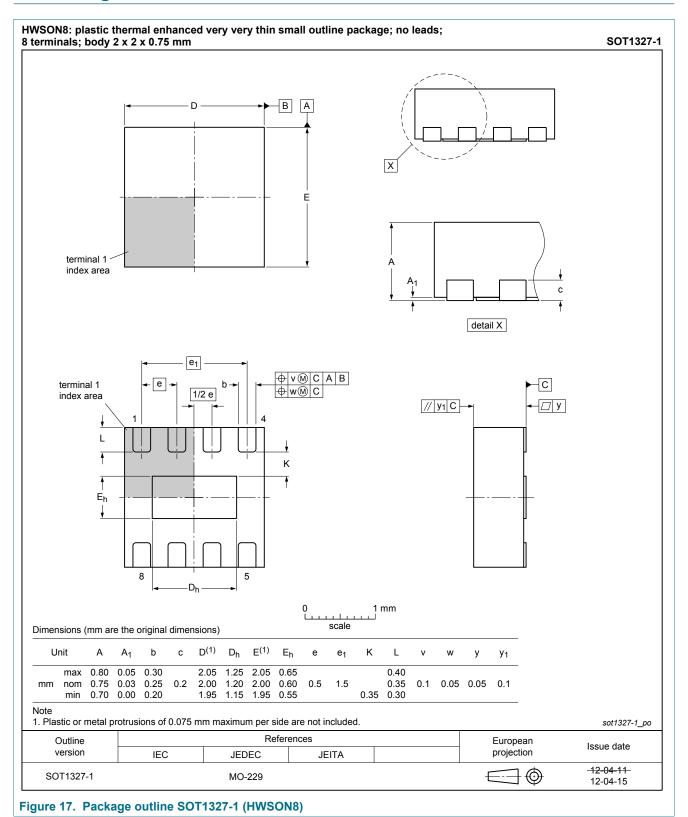
²⁻Tone; tone spacing = 1 MHz, P_0 = 5 dBm per tone. For applications where fast switching is required, the value of C1 and C2 should be changed to 100 pF. Connector and board losses not de-embedded.

For applications where fast switching is required, the value of C1 and C2 should be changed to 100 pF.

Connector and board losses not de-embedded.

Low noise high linearity amplifier

13 Package outline



Low noise high linearity amplifier

14 Abbreviations

Table 12. Abbreviations

Acronym	Description
CDMA	Code Division Multiple Access
ESD	ElectroStatic Discharge
FDD	Frequency-Division Duplexing
GSM	Global System for Mobile Communication
LNA	Low Noise Amplifier
LTE	Long-Term Evolution
RF	Radio Frequency
TDD	Time-Division Duplexing
W-CDMA	Wideband Code Division Multiple Access

15 Revision history

Table 13. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
BGU8052 v.6	20170608	Product data sheet	-	BGU8052 v.5	
Modifications:	<u>Table 4</u> : the maximum value of V _{ESD} has been changed into 1.5 kV				
BGU8052 v.5	20170502	Product data sheet	-	BGU8052 v.4	
Modifications:	<u>Table 5 "Recommended operating conditions"</u> : the minimum value of V _{CC} has been changed into 3.3 V				
BGU8052 v.4	20170120	Product data sheet	-	BGU8052 v.3	
Modifications:	<u>Section 1 "General description"</u> : added BTS1001M according to our new naming convention				
BGU8052 v.3	20160405	Product data sheet	-	BGU8052 v.2	
Modifications:	 3 V to 5 V single supply added to Features and benefits Added Figure 1 "Block diagram" on page 2 An additional curve added Figure "Output power at 1 dB gain compression as a function of supply current; typical values" on page 8 Added remark to R_{bias} in Table 9 "List of components" Added Table 11 "Typical performance BGU8052 application board VCC = 3.3 V" on page 11 				
BGU8052 v.2	20131230	Product data sheet	-	BGU8052 v.1	
Modifications:	 Table 4 on page 3: The maximum value for V_{ctrl(sd)} has been corrected to 3 V. Table 10 on page 11: A correction has been made for the value of G_{ass} at f = 1750 MHz. 				
BGU8052 v.1	20131127	Product data sheet	-	-	

Low noise high linearity amplifier

16 Legal information

16.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
- The term 'short data sheet' is explained in section "Definitions".
- [2] [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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Low noise high linearity amplifier

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Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.